

# BLF7G20LS-140P

Power LDMOS transistor

Rev. 2 — 17 August 2010

Product data sheet

## 1. Product profile

### 1.1 General description

140 W LDMOS power transistor for base station applications at frequencies from 1800 MHz to 2000 MHz.

**Table 1. Typical performance**

Typical RF performance at  $T_{case} = 25\text{ °C}$  in a common source class-AB production test circuit.

Mode of operation	f (MHz)	I <sub>DQ</sub> (mA)	V <sub>DS</sub> (V)	P <sub>L(AV)</sub> (W)	G <sub>p</sub> (dB)	η <sub>D</sub> (%)	ACPR <sub>400k</sub> (dBc)	ACPR <sub>600k</sub> (dBc)	EVM <sub>rms</sub> (%)
CW	1805 to 1880	850	28	125	17	54	-	-	-
GSM EDGE	1805 to 1880	850	28	60	17.5	41	-61	-75	2.7

### 1.2 Features and benefits

- Excellent ruggedness
- High efficiency
- Low R<sub>th</sub> providing excellent thermal stability
- Designed for broadband operation (1800 MHz to 2000 MHz)
- Lower output capacitance for improved performance in Doherty applications
- Designed for low memory effects providing excellent pre-distortability
- Internally matched for ease of use
- Integrated ESD protection
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

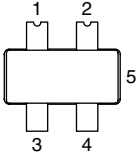
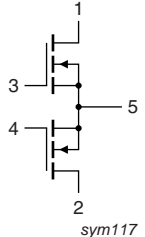
### 1.3 Applications

- RF power amplifiers for base stations and multi carrier applications in the 1800 MHz to 2000 MHz frequency range



## 2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	drain1		 sym117
2	drain2		
3	gate1		
4	gate2		
5	source		

[1] Connected to flange.

## 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BLF7G20LS-140P	-	earless flanged LDMOST ceramic package; 4 leads	SOT1121B

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage		-	65	V
$V_{GS}$	gate-source voltage		-0.5	+13	V
$T_{stg}$	storage temperature		-65	+150	°C
$T_j$	junction temperature		-	200	°C

## 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-c)}$	thermal resistance from junction to case	$T_{case} = 80\text{ °C}$ ; $P_L = 100\text{ W}$	0.41	K/W

## 6. Characteristics

**Table 6. Characteristics**

$T_j = 25\text{ }^{\circ}\text{C}$ ; per section unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0\text{ V}$ ; $I_D = 0.9\text{ mA}$	65	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 10\text{ V}$ ; $I_D = 90\text{ mA}$	1.5	1.9	2.3	V
$I_{DSS}$	drain leakage current	$V_{GS} = 0\text{ V}$ ; $V_{DS} = 28\text{ V}$	-	-	2	$\mu\text{A}$
$I_{DSX}$	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75\text{ V}$ ; $V_{DS} = 10\text{ V}$	14	-	-	A
$I_{GSS}$	gate leakage current	$V_{GS} = 11\text{ V}$ ; $V_{DS} = 0\text{ V}$	-	-	200	nA
$g_{fs}$	forward transconductance	$V_{DS} = 10\text{ V}$ ; $I_D = 2.5\text{ A}$	-	6.45	-	S
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75\text{ V}$ ; $I_D = 3.15\text{ A}$	-	0.15	-	$\Omega$

## 7. Test information

**Table 7. Application information**

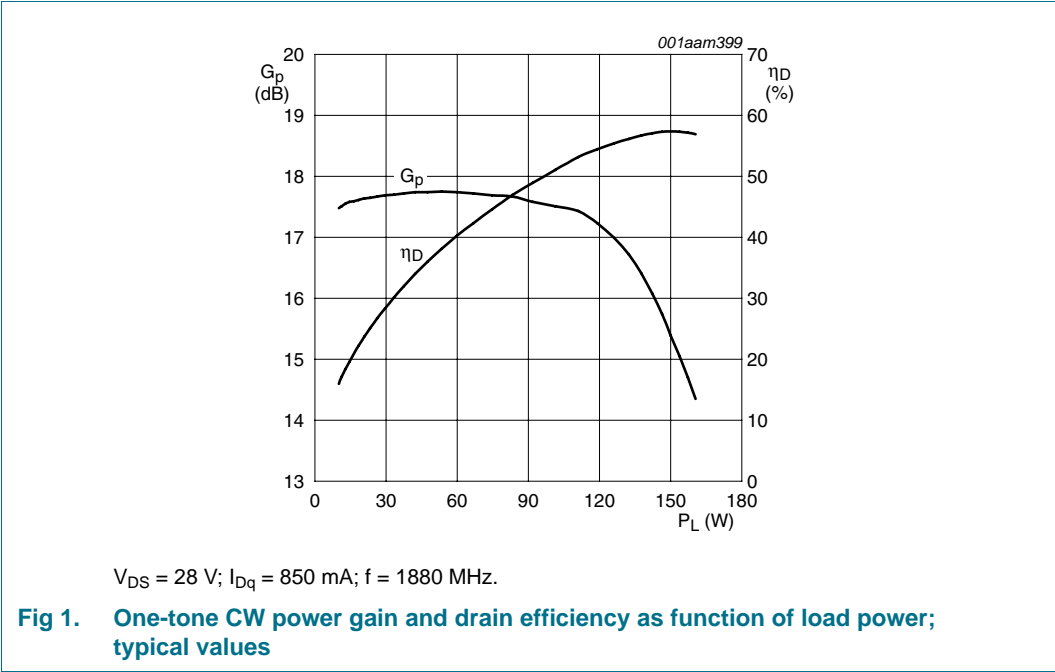
$f = 1805\text{ MHz}$  and  $1880\text{ MHz}$ ; RF performance at  $V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 850\text{ mA}$ ;  $T_{case} = 25\text{ }^{\circ}\text{C}$ ;  
2 sections combined unless otherwise specified; in a class-AB production test circuit.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Mode of operation: GSM EDGE; <math>P_{L(AV)} = 60\text{ W}</math></b>						
$G_p$	power gain		16.3	17.5	-	dB
$RL_{in}$	input return loss		-	-15	-8	dB
$\eta_D$	drain efficiency		37	41	-	%
$ACPR_{400k}$	adjacent channel power ratio (400 kHz)		-	-61	-56.5	dBc
$ACPR_{600k}$	adjacent channel power ratio (600 kHz)		-	-75	-69.5	dBc
$EVM_{rms}$	RMS EDGE signal distortion error		-	2.7	4.0	%
$EVM_M$	peak EDGE signal distortion error		-	8.5	12.5	%
<b>Mode of operation: CW; <math>P_{L(AV)} = 125\text{ W}</math></b>						
$G_p$	power gain		16	17	-	dB
$\eta_D$	drain efficiency		48	54	-	%

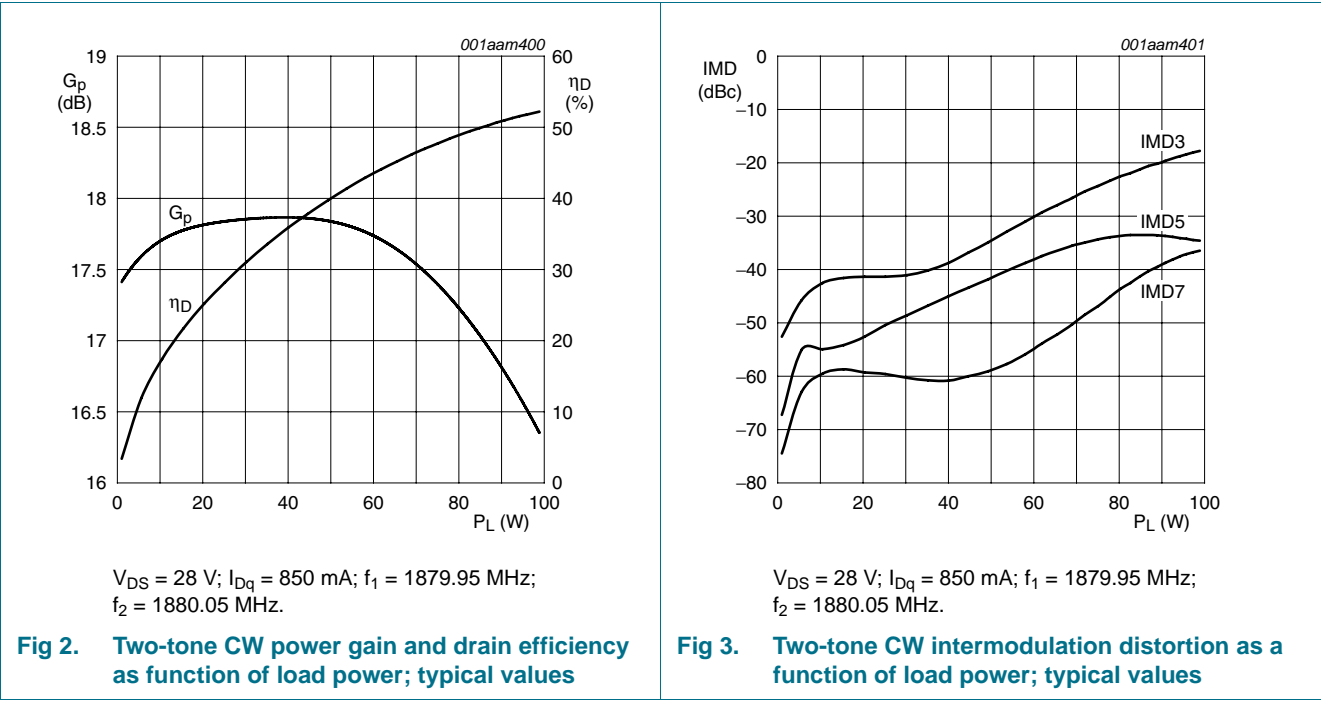
### 7.1 Ruggedness in class-AB operation

The BLF7G20LS-140P is capable of withstanding a load mismatch corresponding to  $VSWR = 10 : 1$  through all phases under the following conditions:  $V_{DS} = 28\text{ V}$ ;  
 $I_{Dq} = 850\text{ mA}$ ;  $P_L = 140\text{ W}$  (CW);  $f = 1805\text{ MHz}$ .

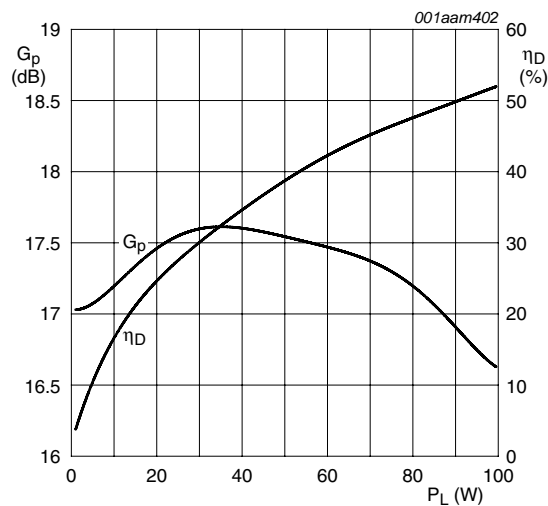
7.2 One-tone CW



7.3 Two-tone CW

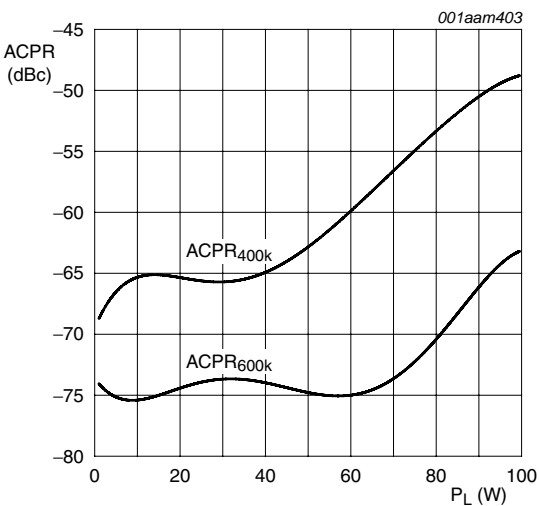


7.4 GSM EDGE



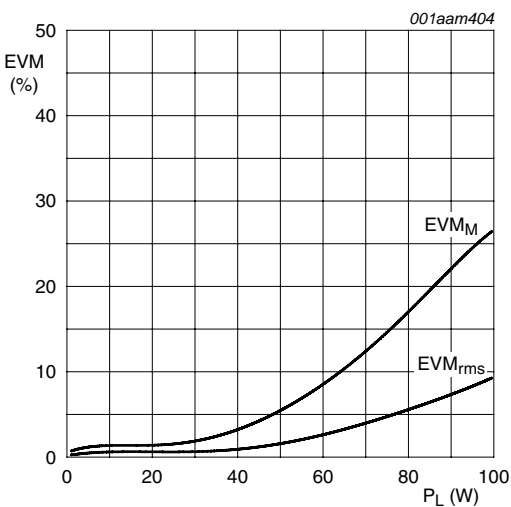
$V_{DS} = 28\text{ V}$ ;  $I_{DQ} = 850\text{ mA}$ ;  $f = 1880\text{ MHz}$ .

Fig 4. GSM EDGE power gain and drain efficiency as function of load power; typical values



$V_{DS} = 28\text{ V}$ ;  $I_{DQ} = 850\text{ mA}$ ;  $f = 1880\text{ MHz}$ .

Fig 5. GSM EDGE ACPR at 400 kHz and at 600 kHz as function of load power; typical values

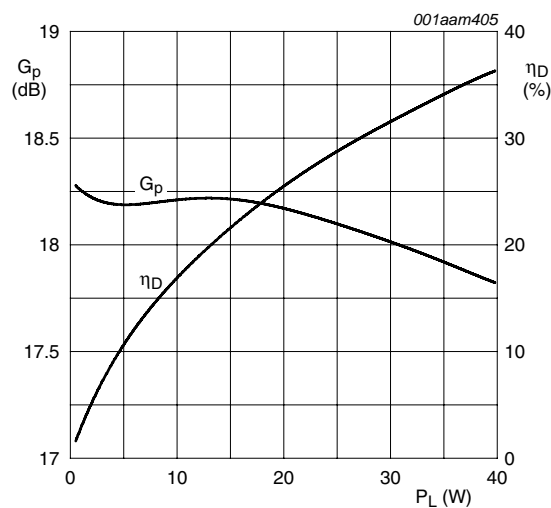


$V_{DS} = 28\text{ V}$ ;  $I_{DQ} = 850\text{ mA}$ ;  $f = 1880\text{ MHz}$ .

Fig 6. GSM-EDGE RMS EVM and peak EVM as function of load power; typical values

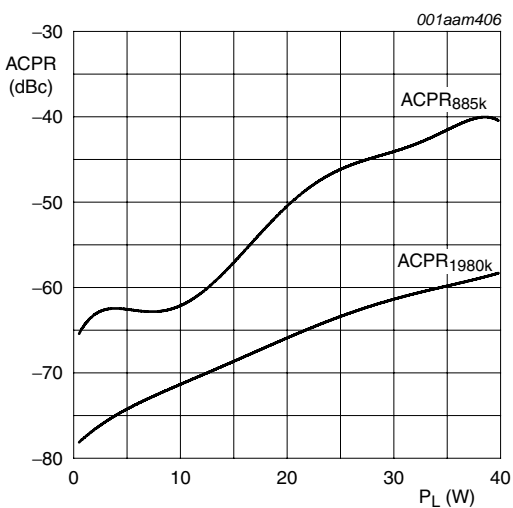
7.5 Single carrier IS-95

Single carrier IS-95 with pilot, paging, sync and 6 traffic channels (Walsh codes 8 - 13).  
PAR = 9.7 dB at 0.01 % probability on the CCDF. Channel bandwidth is 1.2288 MHz.



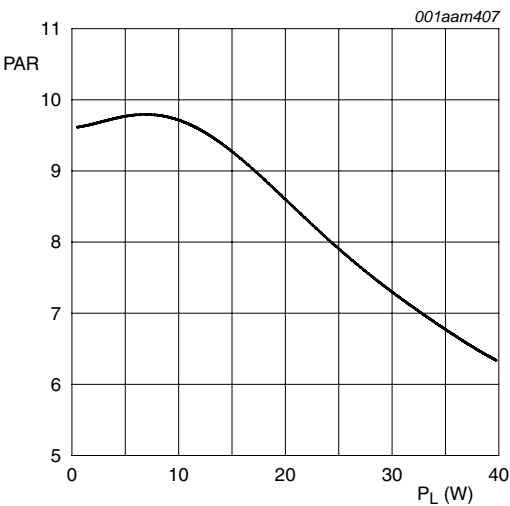
$V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 1080\text{ mA}$ ;  $f = 1880\text{ MHz}$ .

Fig 7. Single carrier IS-95 power gain and drain efficiency as function of load power; typical values



$V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 1080\text{ mA}$ ;  $f = 1880\text{ MHz}$ .

Fig 8. Single carrier IS-95 ACPR at 885 kHz and at 1980 kHz as function of load power; typical values

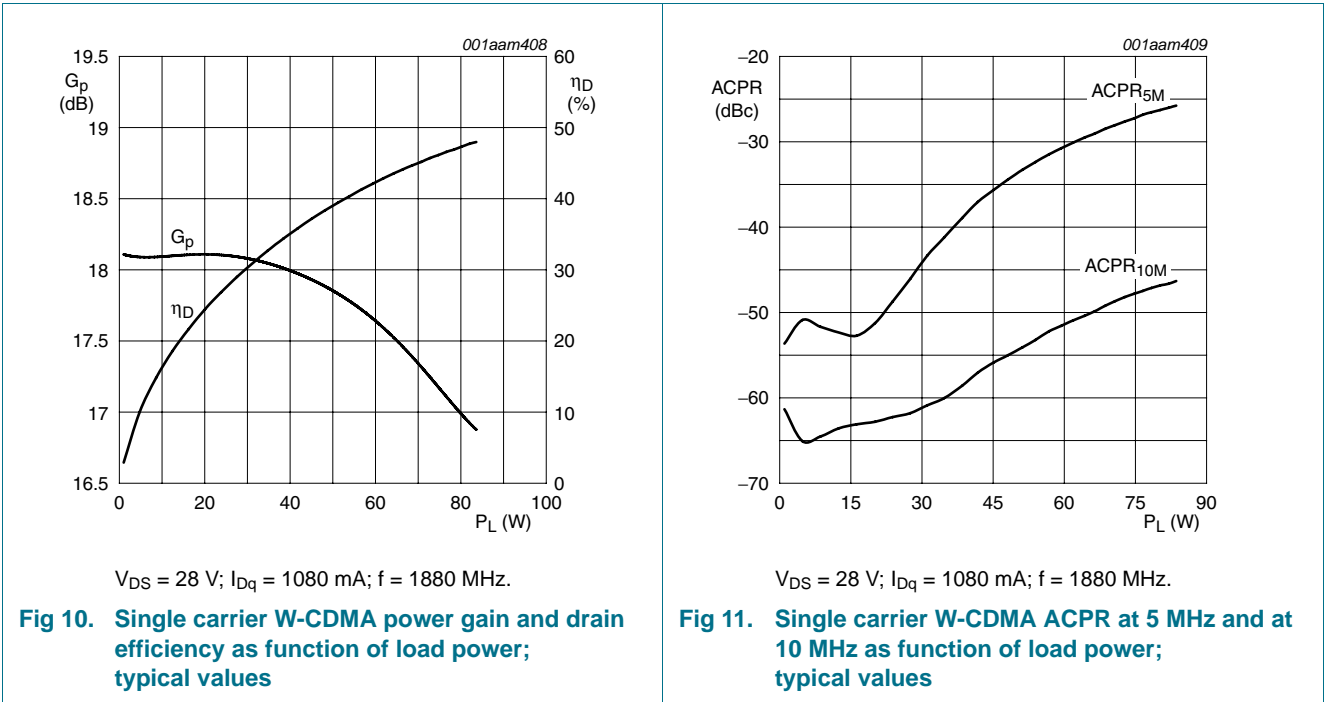


$V_{DS} = 28\text{ V}$ ;  $I_{Dq} = 1080\text{ mA}$ ;  $f = 1880\text{ MHz}$ .

Fig 9. Single carrier IS-95 peak-to-average power ratio as a function of load power; typical values

7.6 Single carrier W-CDMA

3GPP; test model 1; 64 DPCH; PAR = 7.2 dB at 0.01 % probability on CCDF.  
Channel bandwidth is 3.84 MHz.

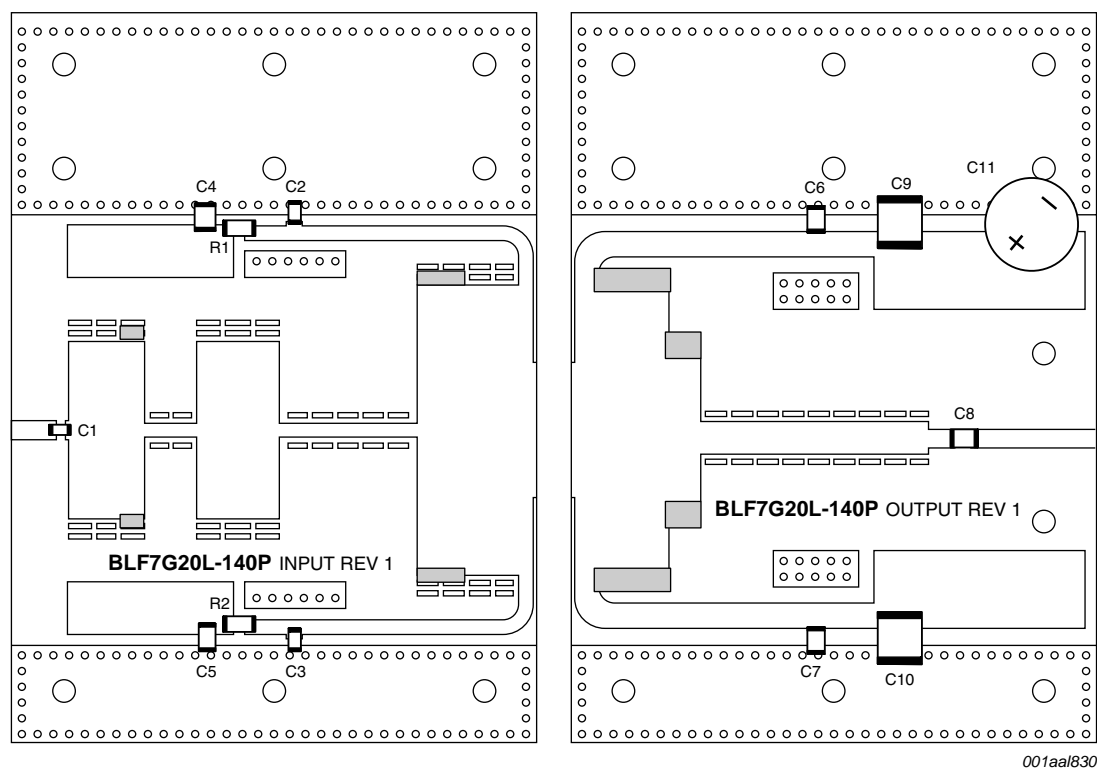


7.7 Test circuit

Table 8. List of components  
For test circuit see [Figure 12](#).

Component	Description	Value	Remarks
C1, C2, C3	multilayer ceramic chip capacitor	24 pF	[1]
C4, C5	multilayer ceramic chip capacitor	4.7 μF	[2]
C6, C7, C8	multilayer ceramic chip capacitor	11 pF	[3]
C9, C10	multilayer ceramic chip capacitor	10 μF	[2]
C11	electrolytic capacitor	470 μF; 63 V	
R1, R2	SMD resistor	12 Ω	Philips 1206

[1] American Technical Ceramics type 100A or capacitor of same quality.  
[2] TDK or capacitor of same quality.  
[3] American Technical Ceramics type 100B or capacitor of same quality.



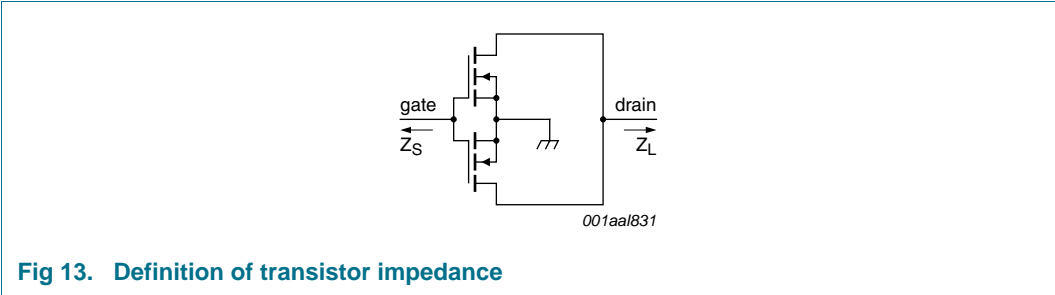
Printed-Circuit Board (PCB): Taconic RF35;  $\epsilon_r = 3.5$  F/m; thickness = 0.76 mm; thickness copper plating = 35  $\mu\text{m}$ .  
 See [Table 8](#) for a list of components.

**Fig 12. Component layout for class-AB production test circuit**

### 7.8 Impedance information

**Table 9. Typical impedance**  
*Typical values valid for both section in parallel unless otherwise specified.*

f	$Z_s$	$Z_L$
MHz	$\Omega$	$\Omega$
1800	$1.1 - j3.8$	$1.8 - j2.8$
1840	$1.3 - j3.7$	$1.7 - j2.6$
1880	$1.2 - j3.8$	$1.6 - j2.5$



**Fig 13. Definition of transistor impedance**



8. Package outline

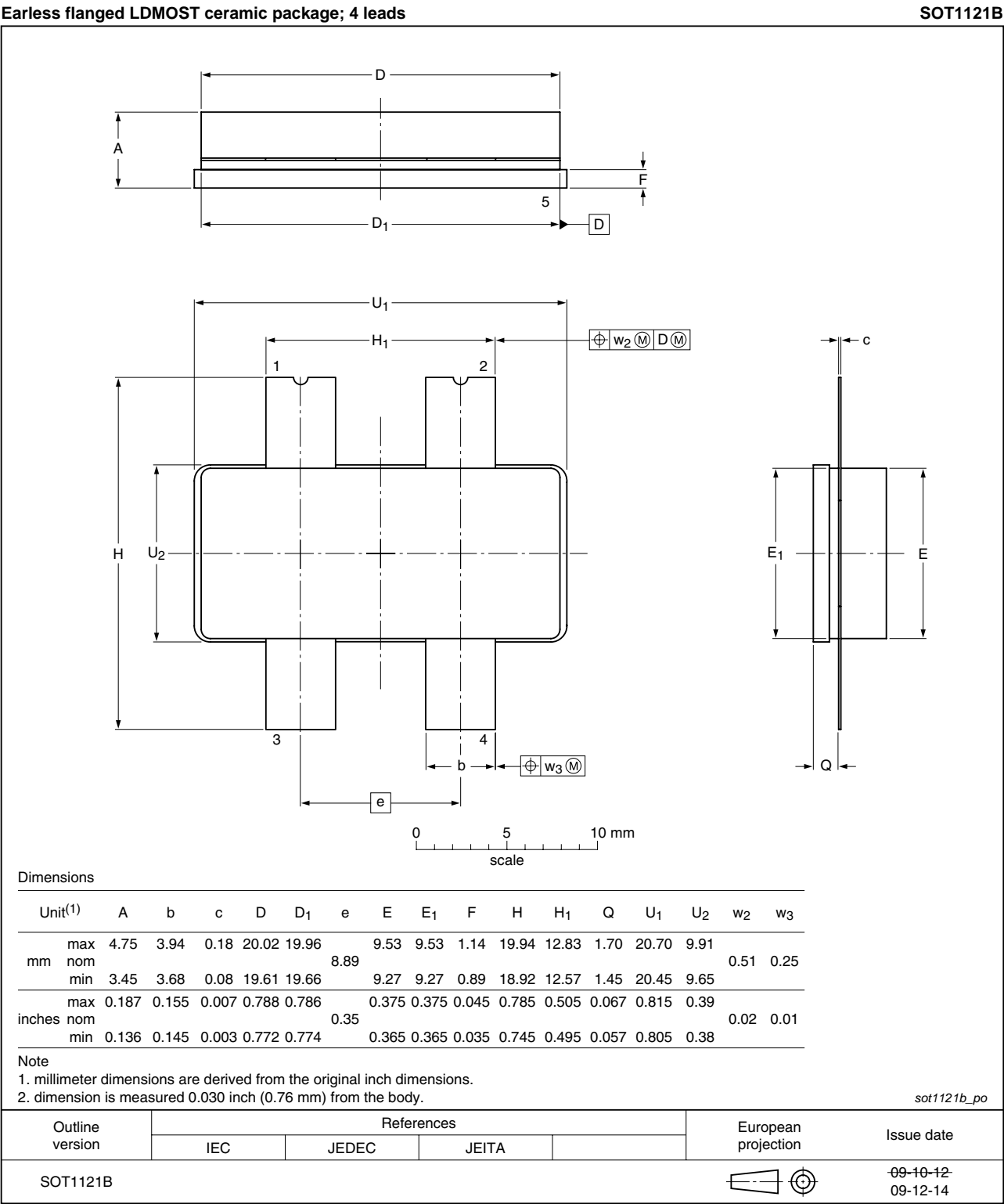


Fig 14. Package outline SOT1121B

## 9. Abbreviations

Table 10. Abbreviations

Acronym	Description
CW	Continuous Wave
EDGE	Enhanced Data rates for GSM Evolution
ESD	ElectroStatic Discharge
GSM	Global System for Mobile communications
IS-95	Interim Standard 95
LDMOS	Laterally Diffused Metal Oxide Semiconductor
LDMOST	Laterally Diffused Metal Oxide Semiconductor Transistor
RF	Radio Frequency
SMD	Surface Mounted Device
VSWR	Voltage Standing Wave Ratio
W-CDMA	Wideband Code Division Multiple Access

## 10. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF7G20LS-140P v.2	20100817	Product data sheet	-	BLF7G20L-140P_7G20LS-140P v.1
Modifications:				
<ul style="list-style-type: none"><li>• This document now only describes the BLF7G20LS-140P.</li><li>• <a href="#">Table 1 on page 1</a>: changed some values.</li><li>• <a href="#">Table 4 on page 2</a>: removed drain current specification.</li><li>• <a href="#">Table 6 on page 3</a>: added typical value for <math>g_{fs}</math>.</li><li>• <a href="#">Table 7 on page 3</a>: changed some values.</li><li>• <a href="#">Section 7.2 on page 4</a>: updated the figures.</li><li>• <a href="#">Section 7.3 on page 4</a>: updated the figures.</li><li>• <a href="#">Section 7.4 on page 5</a>: updated the figures.</li><li>• <a href="#">Section 7.5 on page 6</a>: updated the figures.</li></ul>				
BLF7G20L-140P_7G20LS-140P v.1	20100421	Objective data sheet	-	-

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### 11.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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Date of release: 17 August 2010

Document identifier: BLF7G20LS-140P

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